- 4-Ω Switch Connection Between Two Ports
 - Isolation Under Power-Off Conditions
- Make-Before-Break Feature
- Internal 500-Ω Pulldown Resistors to Ground
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- Package Options Include Plastic Thin Shrink Small-Outline (DGG), Thin Very Small-Outline (DGV), and 300-mil Shrink Small-Outline (DL) Packages

description

The SN74CBTLV16292 is a 12-bit 1-of-2 high-speed FET multiplexer/demultiplexer. The low on-state resistance of the switch allows connections to be made with minimal propagation delay.

When the select (S) input is low, port A is connected to port B1 and R_{INT} is connected to port B2. When S is high, port A is connected to port B2 and R_{INT} is connected to port B1.

The SN74CBTLV16292 is characterized for operation from -40° C to 85° C.

FUNCTION	TADLE
FUNCTION	IABLE

INPUT S	FUNCTION
L	A port = B1 port R _{INT} = B2 port
н	A port = B2 port R _{INT} = B1 port

DGG, DGV, OR DL PACKAGE (TOP VIEW)									
s[$ _1 \cup$	56]∩с						
1A [2	55] NC						
NC [3	54] 1B1						
2A 🛛	4	53	1B2						
NC [5	52	2B1						
3A [6	51	2B2						
NC [7	50	3B1						
GND 🛛	8	49	GND						
4A 🛛	9	48	3B2						
_	10	47	4B1						
5A 🛛	11	46	4B2						
NC	12	45	5B1						
6A 🛛	13	44	5B2						
NC	14	43	6B1						
7A 🛛	15	42	6B2						
NC	16	41	7B1						
V _{CC}	17	40	7B2						
8A [18	39	8B1						
GND	19	38	GND						
NC	20	37	8B2						
9A L	21	36	9B1						
NC	22	35	9B2						
10A 🛛	23	34	10B1						
NC	24	33	10B2						
11A 🛛	25	32	0 11B1						
NC [26	31	11B2						
12A 🛛	27	30	12B1						
№ [28	29	12B2						

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NC - No internal connection



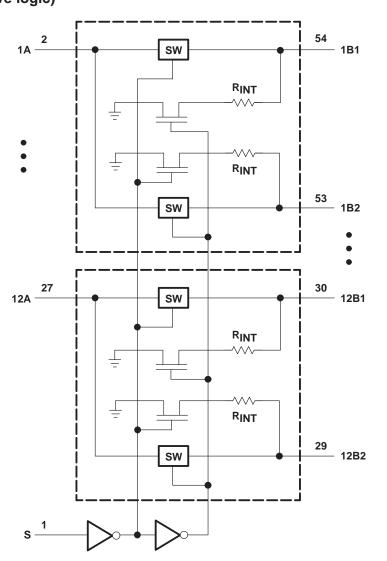
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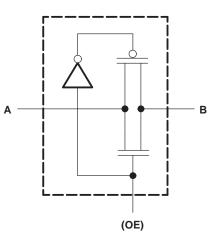


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logic diagram (positive logic)



simplified schematic, each FET switch





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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC}		
Input voltage range, V _I (see Note 1)		–0.5 V to 4.6 V
Continuous channel current		128 mA
Input clamp current, I _{IK} (V _I < 0)		–50 mA
Package thermal impedance, θ_{JA} (see Note 2):	: DGG package	81°C/W
-	DGV package	86°C/W
	DL package	74°C/W
Storage temperature range, Tstg		. –65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions (see Note 3)

			MIN	MAX	UNIT
Vcc	Supply voltage		2.3	3.6	V
	High level control input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.7		V
VIH	VIH High-level control input voltage	$V_{CC} = 2.7 V \text{ to } 3.6 V$	2		v
1	V _{CC} = 2.3			0.7	V
_ vi∟	V _{IL} Low-level control input voltage	$V_{CC} = 2.7 V \text{ to } 3.6 V$		0.8	v
T _A Operating free-air temperature			-40	85	°C

NOTE 3: All unused control inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PAF	RAMETER		TEST CONDITIONS		MIN	TYP‡	MAX	UNIT
VIK		$V_{CC} = 3 V,$	lj = -18 mA				-1.2	V
Ц		V _{CC} = 3.6 V,	$V_{I} = V_{CC} \text{ or } GND$				±1	μΑ
loff		$V_{CC} = 0,$	$V_{I} \text{ or } V_{O} = 0 \text{ to } 3.6 \text{ V}$				10	μΑ
ICC		V _{CC} = 3.6 V,	l _O = 0,	$V_I = V_{CC}$ or GND			10	μA
∆ICC§	Control input	V _{CC} = 3.6 V,	One input at 3 V,	Other inputs at V_{CC} or GND			300	μΑ
Ci	Control input	V _I = 3.3 V or 0				3.5		pF
C _{io}	A or B port	V _O = 3.3 V or 0				22.5		pF
		No. 221	V ₁ = 0	lj = 64 mA		5	8	
		$V_{CC} = 2.3 V,$ TYP at $V_{CC} = 2.5 V$		lj = 24 mA		5	8	
			V _I = 1.7 V,	l _l = 15 mA		11	40	Ω
ron¶			Nr. 0	lj = 64 mA		3	7	52
	$V_{CC} = 3 V$	$V_{I} = 0$	lj = 24 mA		3	7		
			V _I = 2.4 V,	lj = 15 mA		7	15	

[‡] All typical values are at V_{CC} = 3.3 V (unless otherwise noted), T_A = 25°C.

§ This is the increase in supply current for each input that is at the specified voltage level rather than V_{CC} or GND.

¶ Measured by the voltage drop between the A and B terminals at the indicated current through the switch. On-state resistance is determined by the lower of the voltages of the two (A or B) terminals.



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switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figures 1 and 2)

PARAMETER	PARAMETER	FROM (INPUT)		то (OUTPUT)		2.5 V 2 V	V _{CC} = ± 0.3	3.3 V 3 V	UNIT
		(001201)	MIN	MAX	MIN	MAX			
t _{pd} †	A or B	B or A		0.15		0.15	ns		
t _{pd} ‡	S	А	2.5	7.1	2.5	6.7	ns		
ten	S	В	1	5.6	1	5	ns		
^t dis	S	В	1	5	1	4.5	ns		

[†] The propagation delay is the calculated RC time constant of the typical on-state resistance of the switch and the specified load capacitance when driven by an ideal voltage source (zero output impedance).

[‡]This propagation delay was measured by observing the change of voltage on the A output introduced by static levels equal to 3-V or 0 for 3.3 V \pm 0.3 V or V_{CC} or 0 for 2.5 V \pm 0.2 V on B1 and B2 to achieve the desired transition.

switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figures 1 and 2)

PARAMETER	DESCRIPTION		2.5 V 2 V	V _{CC} = 3.3 V ± 0.3 V		UNIT	
		MIN	MAX	MIN	MAX		
t _{mbb} §	Make-before-break time		2	0	2	ns	

§ The make-before-break time is the time interval between make and break, during the transition from one selected port to the other.



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 $V_{CC} = 2.5 V \pm 0.2 V$ TEST **S1** $\odot 2 \times VCC$ S1 Open O Open tpd **500** Ω From Output tPLZ/tPZL $2 \times V_{CC}$ $\sqrt{\Lambda}$ O GND **Under Test** GND tPHZ/tPZH $C_L = 30 \text{ pF}$ **500** Ω (see Note A) -Vcc Output V_{CC}/2 V_{CC}/2 LOAD CIRCUIT Control 0 V ^tPZL ^tPLZ Output • 2 × V_{CC}/3 Vcc Waveform 1 VCC/3 Input Vcc/2 V_{CC}/2 S1 at $2 \times V_{CC}$ V_{OL} + 0.15 V (see Note B) VOL 0 V - tPHZ ^tPZH ^tPLH ^tPHL Output — Vон VOH Waveform 2 V_{OH} – 0.15 V V_{CC}/3 Output V_{CC}/2 V_{CC}/2 S1 at GND 0 V VOL (see Note B) **VOLTAGE WAVEFORMS** VOLTAGE WAVEFORMS **PROPAGATION DELAY TIMES** ENABLE AND DISABLE TIMES

PARAMETER MEASUREMENT INFORMATION

NOTES: A. C₁ includes probe and jig capacitance.

B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control. C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_f \leq 2 ns, t_f \leq 2 ns.

D. The outputs are measured one at a time with one transition per measurement.

E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .

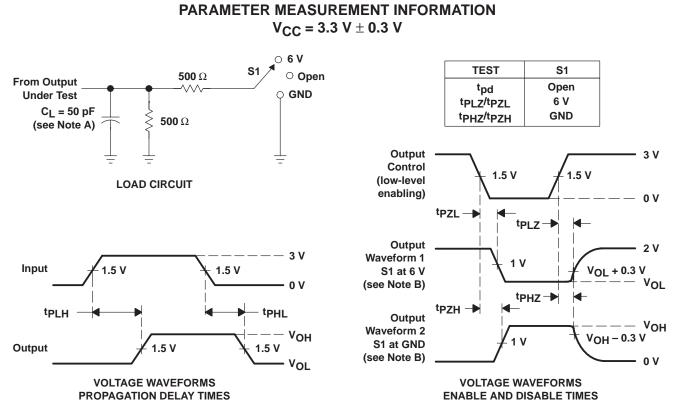
F. tpzL and tpzH are the same as ten.

G. tpl H and tpHI are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms



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NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_f \leq 2.5 ns, t_f \leq 2.5 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. tPLZ and tPHZ are the same as tdis.
- F. t_{P7I} and t_{P7H} are the same as t_{en} .
- G. t_{PLH} and t_{PHL} are the same as t_{pd} .

Figure 2. Load Circuit and Voltage Waveforms



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